## Notice of References Cited Application/Control No. O9/842,089 Examiner Paulos M. Natnael Applicant(s)/Patent Under Reexamination LEE ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,519,009 B1	02-2003	Hanaya et al.	348/564
	В	US-6,661,437 B1	12-2003	Miller et al.	345/810
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	н	US-			
	-	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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